

Search Notes

Application/Control No.

10/075,051

Examiner

Djenane M. Bayard

Applicant(s)/Patent under
Reexamination

WANG ET AL.

Art Unit

2141

SEARCHED

Class	Subclass	Date	Examiner
709	229	1/30/2008	DB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	1/30/2008	db